

Systematic treatment of displacements, strains and electric fields in density-functional perturbation theory

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The methods of density-functional perturbation theory may be used to calculate various physical response properties of insulating crystals including elastic, dielectric, Born charge, and piezoelectric tensors. These and other important tensors may be defined as second derivatives of the total energy with respect to atomic-displacement, electric-field, or strain perturbations, or as mixed derivatives with respect to two of these perturbations. The resulting tensor quantities tend to be coupled in complex ways in polar crystals, giving rise to a variety of variant definitions. For example, it is generally necessary to distinguish between elastic tensors defined under different electrostatic boundary conditions, and between dielectric tensors defined under different elastic boundary conditions. Here, we describe an approach for computing all of these various response tensors in a unified and systematic fashion. Applications are presented for two materials, wurtzite ZnO and rhombohedral BaTiO₃, at zero temperature.

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I. INTRODUCTION

The methods of density-functional theory (DFT)¹ and density-functional perturbation theory (DFPT)^{2,3} have been shown to give a successful description of the dielectric and piezoelectric properties of a wide range of materials in which electronic correlations are not too strong.^{4,5} Many properties of interest can be computed directly from DFT using finite differences (for example, elastic constants computed from the stress arising from a small applied strain, or dynamical effective charges computed from polarizations⁶ arising from small sublattice displacements). On the other hand, the use of DFPT methods is becoming increasingly popular because it can be used to compute such response properties directly, without the need for multiple ground-state calculations, thus providing the desired response properties in a more automated, systematic, and reliable fashion.

As a result, improved DFPT capabilities have been implemented in recent years in several of the computer code packages commonly used by the computational electronic-structure community.^{7,9} This development has been most thorough in the case of the open-source ABINIT computer package,⁷ in which the capability for handling strain perturbations¹⁰ has recently been added to the previous implementation of atomic-displacement and electric-field perturbations. This development opens the prospect for a systematic treatment of three kinds of perturbations in insulating crystals on an equal footing: periodicity-preserving atomic displacements (i.e., zone-center phonons), homogeneous electric fields, and homogeneous strains. These three degrees of freedom are often strongly coupled, especially in polar materials used in modern ferroelectric, piezoelectric, and dielectric applications.

In this work, we show that such a systematic approach is now not only practical, but especially powerful. That is, we show that computing the full set of six elementary (or "bare") response tensors (force-constant, dielectric, elastic-constant, Born-charge, internal-strain, and piezoelectric tensors) associated with these three kinds of perturbations provides an extremely valuable database that can subsequently be used to compute a wide variety of relevant physical properties. Among these, for example, are the physical dielectric, elastic, and piezoelectric tensors (in which atomic displacements have been taken into account), elastic compliances, free-stress dielectric tensors, fixed-electric-displacement elastic tensors, alternative piezoelectric tensors, and electromechanical coupling constants. The ability to access this wide range of secondary properties becomes possible only after the full set elementary response tensors has been systematically computed.

The rest of this paper is organized as follows. In Sec. II, we present the formal development, defining the various elementary response tensors and showing how other response tensors of interest can be derived from these. Then in Secs. III-IV we apply our approach to wurtzite ZnO and rhombohedral BaTiO₃ as two paradigmatic example systems. We first briefly describe the practical details of the calculations in Sec. III, and then present the results for the ground-state properties, elementary response properties, and derived response properties, in Sec. IV. We conclude with a summary in Sec. V. A careful formulation of the theory for the case in which strains and electric fields are simultaneously present is deferred to the Appendix.

II. FORMALISM

A. Elementary response tensors

Consider an insulating crystal with N atoms per unit cell. We choose a reference state in which the lattice vectors are a_1, a_2 , and a_3 , the cell volume is v_0 , and the atomic coordinates are $R_m^{(0)}$. Here m is a composite label (atom and displacement direction) running over $1 \dots 3N$, and we assume that this structure is the equilibrium one in vanishing macroscopic electric field.

We consider three kinds of perturbations applied to such a crystal: (i) displacements u_m of the atoms away from their equilibrium positions, (ii) homogeneous strains ϵ_j where $j = 1 \dots 6$ in Voigt notation, and (iii) homogeneous electric fields E where $E = (E_x; E_y; E_z)$ are Cartesian directions. We restrict our discussion to atomic displacements that preserve the primitive-cell periodicity, i.e., to degrees of freedom corresponding to zone-center phonon modes only. Also, we will restrict ourselves entirely to zero-temperature properties.

The corresponding responses that are conjugate to these three perturbations are (i) forces F_m , (ii) stresses σ_j , and (iii) polarizations P . From these, one can construct the response functions of primary interest: "diagonal" responses $K_{mn} = dF_m/du_n$ (force-constant matrix), $\epsilon = dP/dE$ (dielectric susceptibility), and $C_{jk} = d\sigma_j/d\epsilon_k$ (elastic constants), and "off-diagonal" response tensors $Z_m = dP/du_m$ (Born effective charge), $\gamma_{mj} = dF_m/d\epsilon_j$ (internal strain), and $e_j = dP/d\epsilon_j$ (piezoelectric response). However, in order to define these quantities carefully, it is important to clarify the constraints or boundary conditions that apply to each definition. For example, the elastic constants C_{jk} may be defined allowing or not allowing internal atomic displacements ("relaxed-ion" or "frozen-ion"), or under conditions of fixed electric (E) or displacement (D) field.

We take the approach here of systematically defining all response properties as appropriate second derivatives of the energy E per unit volume with respect to the perturbations. To be more precise, in the presence of strains we define E as the energy per undeformed unit cell volume v_0 , while in the presence of electric fields E is modified to become an electric enthalpy¹¹ by adding a term proportional to $-P \cdot E$, where P is the electric polarization.⁶ (While a direct treatment of finite E -fields is now possible,^{12,13} only in infinitesimal E -fields need to be considered here.) In general, we define E as

$$E(u; E; \epsilon) = \frac{1}{v_0} \left(E_{\text{cell}}^{(0)} + \sum_m F_m u_m + \sum_j \sigma_j \epsilon_j + \sum_j P_j E_j \right); \quad (1)$$

where $E_{\text{cell}}^{(0)}$ is the usual zero-field Kohn-Sham energy per cell¹⁴ of the occupied Bloch functions and v_0 is the deformed cell volume. However, when strains and electric fields are simultaneously present, care is needed in the interpretation of Eq. (1); this is explained in the Appendix, where a more precise formulation is given in the

form of Eq. (A11), which supersedes Eq. (1). In short, the difficulty is connected with the distinction between "proper" and "improper" piezoelectric constants;¹⁵ we should like our formulation to lead to the former and not the latter. The factor of v_0 has been inserted in the last term of Eq. (1) towards this purpose, but this is not sufficient by itself. In addition, Eq. (1) should be rewritten in terms of "natural variables" u, E^0 , and ϵ , where E has been replaced by a reduced electric field E^0 that is defined in Eq. (A5). When partial derivatives are taken with respect to these natural variables, one automatically obtains the "proper" piezoelectric tensors. Indeed, as explained in the Appendix, all appearances of E should be replaced by E^0 , with a similar replacement for polarizations, in the remainder of this paper. However, for the sake of clarity of presentation, this notation has been suppressed in the main body of the paper.

Accordingly, we provisionally write $E = E(u; E^0; \epsilon)$ as a function of arguments u_m, E^0 , and ϵ_j , with the understanding that the notation of the Appendix supersedes the notation used here whenever strains and electric fields are simultaneously present. We then expand around a zero-field reference system as

$$\begin{aligned} E = E_0 &+ A_m u_m + A_j E^0 + A_j \epsilon_j \\ &+ \frac{1}{2} B_{mn} u_m u_n + \frac{1}{2} B_j E^0 E^0 + \frac{1}{2} B_{jk} \epsilon_j \epsilon_k \\ &+ B_m u_m E^0 + B_{mj} u_m \epsilon_j + B_j E^0 \epsilon_j \\ &+ \text{terms of third and higher order}; \end{aligned} \quad (2)$$

We use an implied-sum notation throughout. In this expansion, the first-order coefficients A_m, A_j , and A_j encode the forces ($F_m = v_0 A_m$), polarizations ($P_j = v_0 A_j$), and stresses ($\sigma_j = v_0 A_j$), respectively. (Henceforth we shall assume that the atomic coordinates and strains are fully relaxed in the reference system, so that $A_m = A_j = 0$.) The diagonal block second-order coefficients B_{mn}, B_j and B_{jk} and off-diagonal second-order coefficients B_m, B_{mj} , and B_j correspond to the force-constant, elastic-constant, and susceptibility tensors, and to the Born-charge, internal-displacement, and piezoelectric tensors, respectively.

Inserting appropriate signs and cell-volume factors, the elementary second-derivative response-function tensors are defined as follows. The force-constant matrix

$$K_{mn} = v_0 \frac{\partial^2 E}{\partial u_m \partial u_n} \bigg|_{E^0, \epsilon}; \quad (3)$$

the frozen-ion dielectric susceptibility

$$\epsilon = \frac{\partial^2 E}{\partial E^0 \partial E^0} \bigg|_{u, \epsilon}; \quad (4)$$

and the frozen-ion elastic tensor

$$C_{jk} = \frac{\partial^2 E}{\partial \epsilon_j \partial \epsilon_k} \bigg|_{u, E^0} \quad (5)$$

are the elementary diagonal block tensors, while the off-diagonal blocks are the Born dynamical effective charge tensor

$$Z_{ma} = - \frac{\partial^2 E}{\partial u_m \partial E_a} ; \quad (6)$$

the force-response internal-strain tensor

$$m_j = - \frac{\partial^2 E}{\partial u_m \partial u_j} ; \quad (7)$$

and the frozen-ion piezoelectric tensor

$$e_j = \frac{\partial^2 E}{\partial E \partial u_j} : \quad (8)$$

The bar on quantities \bar{C}_{jk} , and \bar{e}_j indicates a frozen-ion quantity, i.e., the fact that atomic coordinates are not allowed to relax as the electric field or homogeneous strain is applied. Note that the clamped-ion elastic tensor C_{jk} and piezoelectric tensor e_j are generally not physically relevant quantities, except in cases of high symmetry where atomic displacements do not occur to first order in strain. The clamped-ion susceptibility tensor χ is the purely electronic one that is measured in response to AC or optical fields at frequencies well above the phonon-frequency range (corresponding to $\omega \rightarrow \infty$ in the polariton language).

The force-response internal-strain tensor m_j must be distinguished from the displacement-response internal-strain tensor $n_j = m_j (K^{-1})_{mn}$ that describes the first-order displacements resulting from a first-order strain; both occur in the literature, frequently without careful differentiation. The piezoelectric tensor e_j (often denoted alternatively as c_j) describes the change of polarization arising from a strain, or a stress arising from a change of E-field, while the d, g, and h piezoelectric tensors are defined under different constraints and have slightly different physical meanings.¹⁶ Finally, we remind the reader that there is some subtlety in the definition of the piezoelectric tensors related to the specification of the energy functional when both fields and strains are present, leading to a distinction between "proper" and "improper" piezoelectric constants¹⁵ as will be discussed more fully in the Appendix. Throughout this paper, we adopt the convention that all piezoelectric tensors are "proper" ones unless otherwise noted.

We shall refer to the quantities defined in Eqs. (3-8) as the "elementary" or "bare" response tensors. These are the quantities that will be calculated once and for all using the DFPT capabilities of a code package such as ABINIT. All of the derived tensor properties described in the following subsections can then be calculated from these using simple matrix manipulations, as we shall see.

B. Relaxed-ion tensors

Generally, the physical static response properties of interest must take into account the relaxations of the ionic coordinates. This becomes especially important for non-centrosymmetric polar systems, such as ferroelectric ones, where these various effects become coupled. Instead of "clamped-ion" quantities \bar{C} , \bar{e} defined at fixed u , we can define the corresponding "relaxed-ion" or "dressed" response tensors C , e , and χ as follows. To develop expressions for these, we let

$$\mathcal{F}(u; E) = m \ln E(u; E) : \quad (9)$$

Referring back to Eq. (2), setting $\partial E = \partial u_n = 0$, $\partial E = \partial E = 0$, and $\partial E = \partial u_j = 0$, and assuming that the reference configuration is one in which the forces A_m vanish, we find

$$0 = B_{nm} u_m + B_n E + B_{nj} u_j$$

from which it follows that

$$u_m = -(B^{-1})_{mn} [B_{nj} u_j + B_n E] : \quad (10)$$

Defining

$$\bar{\chi} = \frac{\partial^2 \mathcal{F}}{\partial E \partial E} ; \quad (11)$$

$$C_{jk} = \frac{\partial^2 \mathcal{F}}{\partial u_j \partial u_k} ; \quad (12)$$

$$e_j = \frac{\partial^2 \mathcal{F}}{\partial E \partial u_j} ; \quad (13)$$

and using Eqs. (3-8), we find that the physical relaxed-ion dielectric, elastic, and piezoelectric tensors become

$$\chi = \bar{\chi} + \frac{1}{\epsilon_0} Z_m (K^{-1})_{mn} Z_n ; \quad (14)$$

$$C_{jk} = \bar{C}_{jk} + \frac{1}{\epsilon_0} m_j (K^{-1})_{mn} n_k ; \quad (15)$$

$$e_j = \bar{e}_j + \frac{1}{\epsilon_0} Z_m (K^{-1})_{mn} n_j ; \quad (16)$$

respectively.

Note that Eqs. (14-16) cannot be naively evaluated as written because the force-constant matrix K is singular, due to the fact that K has three vanishing eigenvalues associated with translational symmetry. Moreover, in soft-mode systems, other eigenvalues may be close to zero, and care should be taken to distinguish these from the translational ones. For these reasons, we have implemented a careful procedure for obtaining the "pseudo-inverse" of K ; throughout these notes, whenever we refer to K^{-1} , we really mean the pseudo-inverse.

We proceed as follows. (i) We identify the three-dimensional space of acoustic modes (i.e., uniform translations), and construct a $(3N) \times (3N)$ orthogonal matrix

U whose first three columns correspond to these translational modes; the remaining columns of U are formed by Gram-Schmidt orthogonalization of the basis. (ii) We construct $K^0 = U K U^T$, whose upper 3×3 block represents the acoustic subspace and therefore ought to be zero. (iii) We let K_{red}^0 be the lower $(3N-3) \times (3N-3)$ block of K^0 , corresponding to the reduction to the complementary subspace of optical modes. (iv) We invert K_{red}^0 by standard means (taking appropriate measures in case this matrix is nearly singular, as when soft modes have nearly vanishing frequencies). Let the result be denoted as $(K^{-1})_{\text{red}}^0$. (v) We pad $(K^{-1})_{\text{red}}^0$ with zeros in the first three rows and columns to form the $(3N) \times (3N)$ matrix $(K^{-1})^0$. (vi) Finally, we define the pseudo-inverse of K to be $K^{-1} = U^T (K^{-1})^0 U$.

Thus, by construction, the resulting pseudo-inverse K^{-1} is zero in the subspace of translational modes, and is the inverse of the original matrix in the complementary subspace. As a result, any time K^{-1} is multiplied by another tensor, a pre-projection onto the complementary subspace of dimension $3N-3$ is effectively carried out. In other words, the acoustic sum rule is effectively enforced in any operation involving K^{-1} .

C. Other derived tensor quantities

In the previous subsection, we showed how to obtain the static dielectric susceptibility tensor ϵ_{jk} , the elastic tensor C_{jkl} , and the piezoelectric tensor e_j . These quantities are defined under conditions of controlled strain and electric field. From these three ingredients, it is straightforward to form many other useful tensor quantities describing physical properties defined under other constraints or boundary conditions, as we shall see in this section.

1. Dielectric tensors

The susceptibility tensor ϵ_{jk} is defined at fixed (vanishing) strain; the corresponding dielectric tensor is

$$\epsilon^{(0)} = \epsilon_0 (\epsilon_{jk} + \epsilon_{jk}^{(0)}) ; \quad (17)$$

where ϵ_0 is the susceptibility of free space (SI units are used throughout) and the superscript (0) indicates that the derivative is taken at fixed strain. Often one is interested instead in the free-stress dielectric tensor

$$\epsilon^{(s)} = \epsilon_0 \epsilon_{jk}^{(s)} + \epsilon_{jk}^{(0)} \quad (18)$$

which incorporates the free-stress susceptibility $\epsilon_{jk}^{(s)}$. An expression for the latter is easily derived from the elastic enthalpy

$$\mathcal{H}(\epsilon; E) = \min_{\epsilon} \mathcal{H}(\epsilon; E) - \epsilon_j E_j \quad (19)$$

Following a line of reasoning similar to that leading from Eq. (9) to Eqs. (14-16) and setting $\epsilon_j = 0$, one obtains

$$\epsilon^{(s)} = \epsilon^{(0)} + e_j (C^{-1})_{jk} e_k ; \quad (20)$$

Typically, an AC dielectric measurement will access the true static susceptibility $\epsilon^{(0)}$ as long as the frequency is much less than that of sample resonances (elongational, bending, or torsional modes), and $\epsilon^{(s)}$ at frequencies much higher than sample resonances (but much less than phonon frequencies).

Before leaving this subsection, we note that it is convenient to define inverse dielectric tensors

$$\epsilon^{(0)-1} = (\epsilon^{(0)})^{-1} ; \quad (21)$$

$$\epsilon^{(s)-1} = (\epsilon^{(s)})^{-1} \quad (22)$$

for later use.

2. Elastic and compliance tensors

The elastic tensor C_{jkl} defined in Sec. IIB is the one defined under conditions of fixed (vanishing) electric field: $C_{jkl} = C_{jkl}^{(E)}$. It may sometimes be of interest to treat instead the elastic tensor $C_{jkl}^{(D)}$ defined under conditions of fixed electric displacement field D . For example, in the case of a thin film of dielectric material sandwiched between much thicker layers of other insulating host materials, the electrostatic boundary conditions fix the component of D , not E , normal to the interfaces. One readily obtains

$$C_{jkl}^{(D)} = C_{jkl}^{(E)} + e_j \epsilon^{(0)-1} e_k ; \quad (23)$$

It is also straightforward to obtain the corresponding elastic compliance tensors either under zero E -field

$$S^{(E)} = (C^{(E)})^{-1} \quad (24)$$

or under zero D -field

$$S^{(D)} = (C^{(D)})^{-1} \quad (25)$$

boundary conditions.

3. Piezoelectric tensors

The formulation of an energy functional appropriate to the simultaneous treatment of strains and electric fields is rather subtle, as discussed in the Appendix. There, we show that the proper (relaxed-ion) piezoelectric tensor e_{jk} introduced in Sec. IIB may be written as

$$e_j = \frac{\partial P}{\partial \epsilon_j E} \quad (26)$$

or equivalently, by a thermodynamic relation,^{17;16}

$$e_j = \frac{\partial P}{\partial E} ; \quad (27)$$

where it is understood (see Appendix) that in these and subsequent equations, P and E are to be interpreted as the reduced polarization P^0 and electric field E^0 and of Eqs. (A4) and (A5), respectively. This is done so that Eqs. (26) and (27) will yield the proper, rather than the improper, piezoelectric tensor.¹⁵

In view of Eq. (27), e_j is sometimes referred to as a "piezoelectric stress constant." In any case, it is the natural piezoelectric constant defined under conditions of controlled E and σ . On the other hand, the "piezoelectric strain constant" d_j , defined under conditions of controlled E and σ , is equally or even more commonly discussed in the literature; it is defined via

$$d_j = \frac{\partial P}{\partial E} \quad (28)$$

or

$$d_j = \frac{\partial P}{\partial \sigma_j} \quad (29)$$

and is given in terms of e via

$$d_j = S_{jk}^{(E)} e_k \quad (30)$$

as can again be derived from thermodynamic relations.^{17;16} Two other, less commonly used, piezoelectric tensors are g_j and h_j , defined under conditions of fixed $(D; \sigma)$ and $(D; \sigma)$, respectively, and given by

$$g_j = \epsilon^{(D)} d_j ; \quad (31)$$

$$h_j = \epsilon^{(D)} e_j ; \quad (32)$$

where the ϵ are the inverse dielectric tensors defined in Eqs. (21-22). These have the properties

$$\begin{aligned} g_j &= g_j D ; \\ E &= g_j \sigma_j ; \\ h_j &= h_j D ; \\ E &= h_j \sigma_j ; \end{aligned} \quad (33)$$

4. Piezoelectric coupling coefficients

The most common definition of the piezoelectric coupling factor k_j is given by^{16;18}

$$k_j = \frac{\partial P}{\partial \sigma_j} \bigg|_{E=0} : \quad (34)$$

This applies to the case where the field is applied only along j and the only non-zero stress is the one with Voigt

label j . For example, k_{33} is a dimensionless measure of the coupling of electric and strain degrees of freedom along the z axis. Roughly speaking, a coupling factor close to unity implies an excellent impedance match for the material used as an electromechanical transducer between the specified electric and elastic channels (a coupling factor greater than unity is forbidden by stability considerations).¹⁶

Note that k_j in Eq. (34) does not transform like a tensor, and the usual implied sum notation does not apply to this equation. Instead, we can define a tensorially correct, dimensionless coupling tensor via

$$K = [\epsilon^{(D)}]^{1=2} d [\epsilon^{(E)}]^{1=2} ; \quad (35)$$

where an obvious matrix-product notation is used. The standard "singular-value decomposition" can be used to write K as

$$K = U \begin{pmatrix} K_1 & 0 & 0 & 0 & 0 & 0 \\ 0 & K_2 & 0 & 0 & 0 & 0 \\ 0 & 0 & K_3 & 0 & 0 & 0 \end{pmatrix} V^T ; \quad (36)$$

defined by requiring that U and V be orthogonal 3×3 and 6×6 matrices respectively, and that the K should be positive. (Alternatively, the K^2 can be determined as the eigenvalues of the 3×3 symmetric matrix $K K^T = [\epsilon^{(D)}]^{1=2} d C^{(E)} d^T [\epsilon^{(D)}]^{1=2}$.) For each singular value, the corresponding columns of U and V give the pattern of electric field and of strain, respectively, that are directly coupled to one another by K .

The coupling factors can be related to differences between dielectric or compliance tensors defined under different boundary conditions. Starting from Eqs. (18-20) and Eqs. (23-25), one can show

$$\epsilon^{(D)} - \epsilon^{(E)} = d C^{(E)} d^T = [\epsilon^{(D)}]^{1=2} K K^T [\epsilon^{(D)}]^{1=2} ; \quad (37)$$

$$S^{(E)} - S^{(D)} = d^T \epsilon^{(D)} d = [\epsilon^{(E)}]^{1=2} K^T K [\epsilon^{(E)}]^{1=2} ; \quad (38)$$

Specializing to high-symmetry situations in which ϵ is necessarily diagonal, one finds, for example,

$$\frac{\epsilon^{(D)} - \epsilon^{(E)}}{\epsilon^{(D)}} = K^2 ; \quad (39)$$

III. METHODS AND DETAILS OF THE CALCULATIONS

Our ab-initio calculations were carried out using the ABINIT code package.^{7;19} Specifically, we first carried out full structural relaxations for both materials. Next, response-function calculations were carried out in order to obtain first derivatives of the occupied wavefunctions with respect to the perturbations of atomic displacements (i.e., phonons at $q=0$), uniform electric field, and strain. These were then used to compute the elementary second-derivative response-function tensors, Eqs. (3-8),

of Sec. IIA. Except for the diagonal elements of some elementary tensors, this was done using a non-variational expression that only requires input of one of the two corresponding wavefunction derivatives.² (As for the "mixed derivative" tensors ϵ and Z , strain derivatives were used for ϵ and e , and displacement derivatives were used for Z .²⁰) Finally, from these elementary response tensors, the various secondary response tensors of Secs. IIB and IIC are obtained according to the formulas given there. All calculations are at zero temperature.

The DFT and DFPT calculations for ZnO and BaTiO₃ were carried out using Troullier-Martins pseudopotentials²¹ and a plane-wave energy cutoff of 50 hartree. The Zn pseudopotential includes the 3d electrons in the valence, as this has been shown to be important for accurate results.²² An 8 × 8 × 8 and 6 × 6 × 6 Brillouin-zone k-point sampling were used for ZnO and BaTiO₃ respectively. The exchange and correlation effects were treated within the local-density approximation (LDA) in the Ceperley-Alder²³ form with the Perdew-Wang²⁴ parameterization.

Finally, we made one additional modification in the case of BaTiO₃, where it is well known that the usual underestimation of the equilibrium lattice constant associated with the local-density approximation has an unusually profound influence on the ferroelectric distortion, which is very sensitive to cell volume.²⁵ Therefore, to get more physically meaningful results, we carried out the initial structural relaxation with the cell volume constrained to be that of the experimental structure at zero temperature. This is similar in spirit to the use of a "negative fictitious pressure" that is a standard feature of many first-principles based studies of ferroelectric perovskite materials.²⁵

IV. RESULTS FOR TWO SAMPLE SYSTEMS: ZnO AND BaTiO₃

In this section, we consider two paradigmatic systems, wurtzite ZnO and rhombohedral BaTiO₃. The electromechanical properties of ZnO make it a widely used material in mechanical actuators and piezoelectric sensor applications, while BaTiO₃ is a prototypical perovskite ferroelectric material. It is of particular interest to compare and contrast the behavior of these two materials in view of the fact that BaTiO₃ is a soft-mode system, while ZnO is not. This may help provide insight into the role of the soft mode, which can be expected to lead to enhanced piezoelectric and dielectric response and enhanced couplings. We first describe the results of our ground-state DFT calculations, and then present the results for the various linear-response tensors as defined in Sec. II.

Because ZnO is not a soft-mode system, its properties depend only weakly on temperature, so that it is not unreasonable to compare room-temperature experimental results with zero-temperature theory. BaTiO₃ is a di-

TABLE I. Structural parameters of ZnO. Lattice constants a and c in Å; u is dimensionless internal parameter.

	a	c	c/a	u
Present work	3.197	5.166	1.616	0.380
Previous theory ^a	3.286	5.241	1.595	0.383
Expt. ^b	3.250	5.210	1.602	0.382

^aRef. 28.

^bRef. 29.

electric material, as its properties depend crucially on temperature. The room-temperature tetragonal phase has indeed been thoroughly studied, and as a result, its dielectric, elastic, and piezoelectric constants have been systematically measured.^{26,27} However, there are formidable difficulties associated with preparing single-crystal, single-domain samples of the low-temperature rhombohedral phase, and of carrying out dielectric and elastic measurements on such samples at low temperature under well-defined electric and elastic boundary conditions. As a result, almost no reliable experimental values are available for the corresponding materials constants at very low temperature. Therefore, for the purposes of this paper, we have adopted the approach of providing comparisons with experiment for ZnO wherever possible to benchmark our approach, and of presenting our calculations of the low-temperature properties of BaTiO₃ as predictions for a system that is difficult to characterize experimentally.

A. Relaxed structural properties

1. ZnO

The ground state of ZnO is a tetrahedrally coordinated wurtzite structure (space group $P6_3mc$, point group C_{6v}) with four atoms per unit cell. The structure is determined by three parameters: the hexagonal edge a , the height of the prism c , and the internal parameter u . The structural results from our full relaxation are given in Table I. For comparison, an ideal wurtzite with exactly tetrahedral angles and equal-length bonds would have $u = 3/8$ and $c/a = \sqrt{8/3}$. As is typical of DFT calculations, we find that the lattice constants are underestimated by 1-2%.

TABLE II. Relaxed structure of rhombohedral BaTiO₃. Lattice constant a and atomic displacements (relative to ideal cubic positions) in Å; rhombohedral angle α in degrees.

	a	z (Ti)	x (O)	z (O)
Theory	4.00	89.85	0.043	0.049
Expt. ^a	4.00	89.90	0.052	0.048

^aRef. 30.

TABLE III. Frequencies (in cm^{-1}) of the zone-center optical-phonon modes in wurtzite ZnO.

symmetry character	Theory	Expt. ³¹	Expt. ³²
$A_1(\text{TO})$	390	380	380
$A_1(\text{LO})$	548	574	579
B_1	261		
$E_1(\text{TO})$	409	407	413
$E_1(\text{LO})$	552	583	591
E_2	91	101	101
E_2	440	437	444

2. BaTiO₃

BaTiO₃ is a prototypical example of the class of perovskite ferroelectric materials. These materials normally have the paraelectric cubic perovskite structure at high temperature, but then undergo a ferroelectric instability as the temperature is reduced. BaTiO₃ actually goes through a series of three ferroelectric phase transitions as the symmetry is first tetragonal, then orthorhombic, and then rhombohedral, with polarization respectively along [100], [110], and [111], with decreasing temperature. The ground-state rhombohedral structure (space group $R\bar{3}m$, point group C_{3v}) is fully determined by its lattice constant, rhombohedral angle, and the symmetry-allowed internal atomic displacements along the [111] direction. We represent the rhombohedral phase in the hexagonal coordinate system, in which the z axis is along the previous [111] direction. Table II lists the structural parameters of our relaxed BaTiO₃, in which we constrained the atomic volume to be equal to the experimental one as explained in Sec. III. The remaining structural parameters can be seen to be in good agreement with experiment.

B. Dielectric displacement response tensors

1. ZnO

Wurtzite ZnO belongs to space group $P6_3mc$ (C_{6v}^4). Standard group-theory analysis shows that the Γ -point phonon modes can be decomposed as

$$\Gamma_{\text{opt}} = A_1 + 2B_1 + E_1 + 2E_2 \quad (40)$$

in which the A_1 and E_1 modes are both Raman and IR active, while the nonpolar E_2 modes are Raman active only and B_1 modes are silent. Shown in Table III are our computed phonon frequencies compared with two experimental results, showing good agreement with experiment.

Because of the wurtzite symmetry of ZnO, the effective charge tensor Z has only two independent elements, while the force-response internal-strain tensor has only

TABLE IV. Independent elements of the Born effective charge tensor Z (in units of e) and of the force-response internal-strain tensor (hartree/bohr) for wurtzite ZnO.

$Z_{xz}(\text{Zn})$	$Z_{zz}(\text{Zn})$		
2.135	2.163		
$x_5(\text{Zn})$	$x_6(\text{Zn})$	$z_3(\text{Zn})$	$y_1(\text{O})$
9.5	15.0	18.7	16.7

four independent elements. We present results for both tensors in Table IV. For this semiconductor material, it can be seen that the effective charge is very close to the nominal ionic charge.

2. BaTiO₃

The low-temperature phase of BaTiO₃ has a rhombohedral structure which belongs to the $R\bar{3}m$ space group. According to a group-theory analysis, the zone-center phonon frequencies can be decomposed as

$$\Gamma_{\text{opt}} = 3A_1 + 4E_1 + A_2 \quad (41)$$

The A_1 and E_1 modes are both IR and Raman active, while the A_2 mode is silent. Table V gives the calculated phonon frequencies at the Γ -point. (The A_2 mode at 278 cm^{-1} and the E_1 modes at 293 cm^{-1} are the ones derived from the silent F_{2u} modes of the undistorted cubic structure; because the distortion is weak, the LO-TO splitting of these E_1 modes is negligible.) The results are very similar to those of the previous theoretical study of Ghosez.³³ While we are not aware of detailed experimental information about phonon frequencies at very low temperature, we note that measurements just below the orthorhombic to rhombohedral phase transition temperature indicate phonon frequencies in three regions ($100\text{--}300 \text{ cm}^{-1}$, $480\text{--}580 \text{ cm}^{-1}$, and $680\text{--}750 \text{ cm}^{-1}$) in qualitative agreement with our zero-temperature calculations.

We also calculated the atomic Born effective charges for this phase, but in view of the lower symmetry and larger number of independent elements, we have not listed them all here (our results are again very similar

TABLE V. Phonon frequencies (in cm^{-1}) at the Γ -point for rhombohedral BaTiO₃.

Phonon mode	Frequency	Phonon mode	Frequency
$A_1(\text{TO } 1)$	169	$E(\text{TO } 1)$	164
$A_1(\text{LO } 1)$	179	$E(\text{LO } 1)$	175
$A_1(\text{TO } 2)$	255	$E(\text{TO } 2)$	206
$A_1(\text{LO } 2)$	460	$E(\text{LO } 2)$	443
$A_1(\text{TO } 3)$	511	$E(\text{TO } 3)$	472
$A_1(\text{LO } 3)$	677	$E(\text{LO } 3)$	687
A_2	278	E	293

TABLE VI. Dielectric tensors of ZnO and BaTiO₃ (in units of ϵ_0).

		Present theory			Experiment	
	Index	ϵ_{ij}			ϵ_{ij}	
ZnO	11	5.76	10.31	11.09	3.70 ^a	7.77 ^a
	33	5.12	10.27	12.67	3.78 ^a	8.91 ^a
BaTiO ₃	11	6.20	68.75	264.75	6.19 ^b	
	33	5.79	37.44	49.51	5.88 ^b	

^aRef. 34.

^bRef. 35.

to those of Ref. 33). The cation results are easily given as $Z_{xx}(\text{Ba}) = Z_{yy}(\text{Ba}) = 2.78$, $Z_{zz}(\text{Ba}) = 2.74$, $Z_{xx}(\text{Ti}) = Z_{yy}(\text{Ti}) = 6.64$, and $Z_{zz}(\text{Ti}) = 5.83$. The effective charge tensors are non-diagonal and non-symmetric for the oxygens; we mention only that the eigenvalues of the symmetric parts of these tensors cluster around 2 and 5, i.e., not much changed from their cubic-phase values. Similarly, we have computed the full internal-strain tensor for rhombohedral BaTiO₃, but we have chosen not to present the details here because of the complicated form of this tensor involving a large number of independent elements.

C. Dielectric tensors

We now turn to a discussion of the computed dielectric tensors for wurtzite ZnO and rhombohedral BaTiO₃, which are presented in Table VI. Because of the high point-group symmetry, the dielectric tensors have only two independent elements. Recall that the clamped-ion tensor, the fixed-strain relaxed-ion tensor, and the free-stress relaxed-ion tensor ϵ^{fsl} are defined through Eqs. (14) and (17-20). While the results for the purely electronic dielectric tensors are in good agreement with experiment for BaTiO₃, we find that our LDA theory significantly overestimates the electronic dielectric response of ZnO. Hill and Waghmare,²² also using an LDA pseudopotential approach, found $\epsilon_{33} = 4.39$, not as large as our 5.76, but still much larger than the experimental 3.70. At least some of this overestimate is undoubtedly attributable to the LDA (and is connected with the underestimation of the gap in LDA), but the choice of pseudopotentials also seems to play a role. The computed lattice contributions $\epsilon_{11}^{\text{lat}} = 4.55$ and $\epsilon_{33}^{\text{lat}} = 5.15$ are in better agreement with the experimental values of 4.07 and 5.13 respectively.

While the clamped-ion tensors are not so different for these two materials, the lattice contribution is clearly much bigger for the BaTiO₃ case. That is, while the lattice contribution ϵ^{lat} is about the same size as the purely electronic one ϵ^{el} for ZnO, it is almost 10 times larger in BaTiO₃. This difference clearly reflects the fact

there is a soft ferroelectric mode present in the latter material. (Here, we use "soft" in the sense of a mode that has a small, but positive frequency; it is, of course, closely related to the imaginary-frequency unstable mode computed for the cubic structure, which condenses out to form the ferroelectric rhombohedral phase.) In the semiconductor ZnO, on the other hand, no such soft mode is present.

The last column presents our results for the free-stress dielectric tensors ϵ^{fsl} that are related to the fixed-strain tensors via Eq. (20). The tensors ϵ^{fsl} and ϵ^{fsl} are the same in higher-symmetry crystals, but in the presence of piezoelectric coupling, they are, in general, different. The free-stress tensors are always larger than the fixed-strain ones because the additional strain relaxation occurs so as to allow further polarization to develop in the direction of the applied field. We can see that the changes are modest for ZnO (on the order of 10-20%), which is not a soft-mode system. On the other hand, they are much more profound for the case of BaTiO₃, where most notably an order-of-magnitude change occurs for ϵ_{11} . This is related to the large value of the piezoelectric coupling factor k_{15} , as we will see later in Sec. II C 4. Essentially, it arises because the polarization vector is rather soft with respect to rotation away from the z axis, so that the electric susceptibility is large in the x-y plane.

D. Elastic tensors

We now consider the various elastic tensors. Recall that the clamped-ion elastic tensor C^{cl} of Eq. (5) is just the second derivative of the unit-cell energy with respect to homogeneous strains, without allowing for internal structural relaxations, while the physical elastic tensor C of Eq. (15) does include such relaxations. This tensor C (written more explicitly as $C^{(E)}$) usually defined under conditions of fixed macroscopic electric field, but it is sometimes of interest to consider the elastic tensor $C^{(D)}$ of Eq. (23) defined instead under conditions of fixed electric displacement field. These are identical for higher-symmetry (e.g., centrosymmetric) crystals, but that is not the case here. The compliance tensors S are defined as the inverses of the corresponding elastic tensors C .

The results of our calculations of these tensors are displayed in Table VII and VIII for ZnO and BaTiO₃ respectively. The lower point-group symmetry of BaTiO₃ is reflected in the presence of an additional symmetry-allowed element C_{14} . Actually, there are only five independent elements for ZnO, since $C_{66} = (C_{11} - C_{12})/2$ and $S_{66} = 2(S_{11} - S_{12})$ by symmetry.¹⁷ Similarly, there are really only six independent elements for BaTiO₃; in addition to the same relation, one also has $C_{66} = (C_{11} - C_{12})/2$, $S_{66} = 2(S_{11} - S_{12})$, $C_{56} = C_{14}$, and $S_{56} = 2C_{14}$. Our results for the elastic constants of ZnO can be seen to be in good agreement with previous theory and with experiment (last columns of Table VII).

TABLE VII. Clamped-ion (C) and relaxed-ion (C) elastic tensors at constant E , relaxed ion ($C^{(D)}$) elastic tensor at constant D (GPa), and corresponding compliance tensors (S , S , and $S^{(D)}$) (TPa⁻¹), for wurtzite ZnO. Previous theoretical and experimental results are also given for C for comparison.

Index	Present theory						Theo. ^a	Expt. ^b
	C	C	$C^{(D)}$	S	S	$S^{(D)}$	C	C
11	305	226	231	3.86	7.79	7.56	246	209
12	107	139	144	1.20	3.63	3.93	127	120
13	77	123	114	0.61	2.12	1.58	105	104
33	333	242	260	3.29	6.28	5.23	246	211
44	62	40	43	16.23	24.69	23.21	56	44
66	99	44	44	10.12	22.84	22.73		

^aRef. 28.

^bRef. 36.

TABLE VIII. Clamped-ion (C) and relaxed-ion (C) elastic tensors at constant E , relaxed ion ($C^{(D)}$) elastic tensor at constant D (GPa), and corresponding compliance tensors (S , S , and $S^{(D)}$) (TPa⁻¹), for rhombohedral BaTiO₃.

Index	C	C	$C^{(D)}$	S	S	$S^{(D)}$
11	349	277	318	3.32	5.85	3.65
12	106	79	93	0.82	2.94	0.95
13	96	41	81	0.72	0.45	0.68
14	8.4	45	19	0.31	8.17	0.89
33	334	264	323	3.41	3.93	3.44
44	110	48	97	9.12	35.85	10.63
65	8.3	45	19	0.63	16.33	1.78
66	121	99	113	8.28	17.58	9.18

We notice that the physical elastic C_{jk} are generally smaller than the frozen-ion ones C_{jk} (at least for diagonal elements), since the additional internal relaxation allows some of the stress to be relieved. By the same token, diagonal S values are larger than S ones, reflecting the increased compliance allowed by the relaxation of the atomic coordinates. As for the dielectric constants, the differences are substantially smaller for ZnO than for BaTiO₃, as a result of the soft-mode contribution in the latter material. The constraint of fixed electric displacement field has the effect of suppressing some of this internal relaxation (for essentially the same reason that longitudinal optical phonons are stiffer than transverse optical ones). This additional stiffness results in larger diagonal $C^{(D)}$ values than C values, and lower diagonal $S^{(D)}$ values than S values. However, the differences between $C^{(D)}$ and C tensors are generally smaller than the differences between C and C tensors, especially for ZnO.

E. Piezoelectric tensors

The bare (or "frozen-ion") piezoelectric tensor e_j is just given by the mixed second derivatives of unit cell energy with respect to electric field E and strain ϵ_j , defining internal atomic coordinates in strict proportion to the homogeneous strain. The full piezoelectric tensor e_j also takes into account the contributions from the lattice, as described in Eq. 16. The total number of independent piezoelectric tensor members is determined by the point group of material. Rhombohedral BaTiO₃ (point group C_{3v}) has a lower symmetry than that of wurtzite ZnO (C_{6v}), so we may expect more independent elements in the former. Indeed, a symmetry analysis¹⁷ shows that ZnO has only three independent tensor elements, namely e_{31} and e_{33} describing polarization along the c axis induced by uniaxial c -axis or biaxial ab -plane strains, while e_{24} describes the polarization induced by shear strains. For BaTiO₃, the symmetry is slightly lower, and as a result there is a fourth independent tensor element in this case.

In Table IX and X, we present our results for piezoelectric tensors for these two materials. We also give the results for the d_j tensor as defined in Eq. 30. Our results for the e_j matrix for ZnO are consistent with the previous theory.^{22;37;38} (Table X shows vector elements for BaTiO₃, not four, but in fact $e_{21} = e_{16}$ and $2d_{21} = d_{16}$ by symmetry.¹⁷)

Recall that the frozen-ion and relaxed-ion piezoelectric tensors are defined by Eqs. (8) and (16), in which the relaxed-ion piezoelectric tensor incorporates contributions from lattice relaxation. For the same reason as discussed previously for the case of the dielectric and elastic tensors, the difference between the above two tensors (e.g. e and e) is much bigger for BaTiO₃ than for ZnO, as expected from the presence of the soft mode in the perovskite material. Also, note that the electronic and lattice contributions have opposite signs, with the lattice contribution being the larger of the two, as is common for other dielectric materials.

TABLE IX. Clamped-ion e (C/m^2), relaxed-ion e (C/m^2), and relaxed-ion d (pC/N) piezoelectric tensors for wurtzite ZnO . Previous theoretical and experimental results are also given for e and d for comparison.

Index	Present theory			Theo. ^a		Expt. ^b	
	e	e	d	e	d	e	d
31	0.37	0.67	5.5	0.55	3.7	0.62	5.1
33	0.75	1.28	10.9	1.19	8.0	0.96	12.3
15	0.39	0.53	13.1	0.46	8.2	0.37	8.3

^aRef. 28.

^bRef. 36.

TABLE X. Clamped-ion e (C/m^2), relaxed-ion e (C/m^2), and relaxed-ion d (pC/N) piezoelectric tensors for rhombohedral BaTiO_3 .

Index	e	e	d
21	0.23	2.91	70.1
31	0.05	3.03	6.8
33	0.19	4.44	14.7
15	0.18	5.45	243.2
16	0.23	2.91	140.2

In view of this partial cancellation of terms of opposite sign, accurate calculations of e and d coefficients are particularly delicate. We find that our results for the 31 and 33 elements of the e and d coefficients of ZnO are in reasonably good agreement with experiment (slightly better than previous Hartree-Fock calculations²⁸), whereas we somewhat overestimate the shear coefficients e_{15} and d_{15} (slightly more so than in the Hartree-Fock theory²⁸).

F. Electromechanical coupling constants

We compute and present in Table XI the piezoelectric coupling factors k_{33} , k_{31} , and k_{15} defined in Eq. (34) for both ZnO and BaTiO_3 . We also calculate the singular values \tilde{K} of the \mathbf{K} matrix of Eq. (35). Because of the axial symmetry, these are arranged into a pair of degenerate values $\tilde{K}_1 = \tilde{K}_2$ corresponding to in-plane electric fields, and a \tilde{K}_3 corresponding to axial fields. (In fact, due to the symmetry, \tilde{K} can be calculated in practice as just $[(\tilde{d}^T \mathbf{C}^{(E)} \tilde{\mathbf{d}})]^{-1/2}$.) These \tilde{K} values are also given in Table XI.

Roughly speaking, the couplings given in the first three lines of Table XI are associated with "symmetry-preserving \textit{polarization stretching}'' degrees of freedom, while those in the last two lines correspond to "polarization rotation'' modes. Note that $k_{15} = \tilde{K}_1$ for ZnO but not for BaTiO_3 ; this is a feature of symmetry, arising because an electric field E_1 couples uniquely to ϵ_5 in ZnO , but also to ϵ_6 in BaTiO_3 . Also, we can see that $\tilde{K}_1 = k_{15}$ and $\tilde{K}_4 = \max(k_{33}, k_{31})$ in both materials, since \tilde{K} describes the optimal coupling between electric and elastic

TABLE XI. Dimensionless piezoelectric coupling factors. The first three correspond to E -fields longitudinal to the crystal axis; the last two are transverse. Coupling constants \tilde{K}_1 and \tilde{K}_3 are obtained from singular-value analysis of the coupling tensor \mathbf{K} (see text).

	ZnO	BaTiO_3
k_{33}	0.41	0.35
k_{31}	0.19	0.13
\tilde{K}_3	0.44	0.49
k_{15}	0.27	0.84
\tilde{K}_1	0.27	0.86

channels.

Comparing the two materials, we see that the coupling factors are rather comparable in the polarization stretching channel; evidently, the soft mode does not play such a profound role there. In contrast, the coupling factor k_{15} is very large in BaTiO_3 ; in fact, it is not far from unity, the maximum value consistent with stability. Indeed, this is precisely because the crystal is not far from being unstable with respect to a rotation of the polarization away from the rhombohedral axis (precisely the type of distortion that would carry it to the orthorhombic phase, from which it evolved as the temperature was reduced below the orthorhombic-rhombohedral phase transition temperature that occurs experimentally at $\sim 180\text{K}$). The large k_{15} is also strongly connected to the large difference between ϵ_5 and ϵ_6 in Tab. VI as already discussed at the end of Sec. IV C.

The calculated value $k_{15} = 0.84$ for BaTiO_3 is quite respectable; it is in the range of the values of $k_{15} = 0.25\{0.30\}$ ³⁹ for the PMN-PT and PZN-PT single-crystal piezoelectrics on the rhombohedral side of the morphotropic phase boundary. Unfortunately, the fact that this large coupling occurs only at very low temperature probably makes it useless for practical applications. On the other hand, the present work suggests that if a material like BaTiO_3 could somehow be stabilized in the rhombohedral phase at room temperature, it might have very promising piezoelectric properties.

In summary, we have developed a method that systematically treats the effects of perturbations associated with atomic displacements, electric fields and strains in insulating crystals, so that physical quantities expressible as second derivatives of the total energy can be computed efficiently. In the first step, six elementary tensors are computed once and for all using the methods of DFT: the force-constant matrix, the Born charge tensor, the internal-strain tensor, and the frozen-ion dielectric, elastic, and piezoelectric tensors. The internal-displacement degrees of freedom are then eliminated to give physical low-frequency dielectric, elastic, and piezoelectric tensors, defined under boundary conditions of controlled electric field E and strain ϵ . We have also shown how these can then be manipulated to obtain various related tensor properties of interest such as the free-stress dielectric tensor, the fixed- D elastic and compliance tensors, and various piezoelectric tensors and electromechanical coupling factors. Such a systematic approach is especially important in polar crystals, in which the atomic-displacement, electric-field, and strain degrees of freedom are strongly coupled in complex ways.

We have applied our approach to compute these tensor properties for two paradigmatic crystals, ZnO and BaTiO₃, at zero temperature. These materials differ most significantly in that there is a ferroelectric soft mode that has condensed, but still remains rather low in frequency, in the latter material. The calculations are subject to several approximations, most notably the LDA itself (and its associated lattice-constant error, which has been removed by hand for the case of BaTiO₃ { see Sec. III), but also the frozen-core approximation (as implemented through the use of pseudopotentials) and the neglect of zero-point fluctuations. Nevertheless, we validate the approach by finding reasonably good agreement between theory and experiment for most quantities in the case of ZnO, despite the fact that the experiments are room-temperature ones. The largest discrepancies are for the purely electronic dielectric tensor elements ϵ_{11} and ϵ_{33} , the shear piezoelectric coupling e_{15} , and to a lesser extent, derived quantities that depend on these elementary ones. In the case of BaTiO₃, where low-temperature experiments on single-crystal, single-domain samples under well-defined boundary conditions are not available, our calculations provide useful predictions of the material constants. In particular, we find an encouraging value of 0.84 for the k_{15} electromechanical coupling constant, and argue that this is associated with the proximity of the orthorhombic phase.

We wish to emphasize that the usefulness of the general approach advocated here transcends the particular implementation of it (here DFT/LDA, pseudopotentials, etc.). For example, similar calculations might be carried out with Hartree-Fock methods using localized orbitals²⁸ or, eventually, using "LDA+ U ", dynamical mean-field the-

ory, or quantum Monte Carlo methods. In this case, the six elementary tensors of Eqs. (3-8) will first need to be calculated using methods appropriate to the particular type of electronic-structure method used. However, the subsequent manipulations described in Secs. IIB and IIC can then be carried through in identically the same way as done here.

Finally, we note that the approach described here can be extended to include other types of perturbations, such as chemical ones, and to the treatment of higher-order responses (e.g., anharmonic elastic constants, nonlinear dielectric responses, and electrostriction effects), providing possible directions for future developments of the method.

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APPENDIX A: SIMULTANEOUS TREATMENT OF STRAINS AND ELECTRIC FIELDS

The formulation of an energy functional, and the definition of response functions in terms of its second derivatives, is somewhat subtle in the case that electric fields and strains are simultaneously present. The purpose of this Appendix is to give a careful treatment of the theory in this case. Except where noted, the notation here follows that of Sec. IIB in that the internal displacements u_m are assumed to have been integrated out (i.e., internal displacements u_m do not appear explicitly).

We begin introducing the deformation tensor e in the Cartesian frame via

$$dr = e \cdot r \quad (A1)$$

(implied sum notation) where dr is the deformation of the medium from its undeformed position r . We consider deformations taking the form of homogeneous strains and rigid rotations, so that the antisymmetry part of the deformation tensor e describes the rotational part, while its symmetric part is just the strain tensor

$$= \frac{1}{2} (e + e^T) : \quad (A2)$$

The improper piezoelectric tensor is defined as

$$e^{impr} = \frac{dP}{de} : \quad (A3)$$

The name "improper" reflects that fact that e^{impr} contains contributions that are spurious in a certain sense.¹⁵

For example, if we consider a pure rotation of a spontaneously polarized crystal about an axis that does not coincide with P , then dP does not vanish, and consequently e^{impr} has a component that is antisymmetric under interchange of i and j . Similarly, if we consider a uniaxial or biaxial compression in the $x-y$ plane of a ferroelectric modeled as a lattice of discrete rigid dipoles oriented in the z direction, the polarization will change even if the dipoles do not, because the polarization is defined as the dipole moment per unit volume. This, too, is an essentially spurious effect. By contrast, the "proper" piezoelectric tensor will be defined so as to vanish in either of these situations.

In the presence of a strain, it is convenient to introduce reduced or rescaled polarizations P^0 and electric fields E^0 via

$$P^0 = (e^{-1}) P \quad (\text{A } 4)$$

and

$$E^0 = e E; \quad (\text{A } 5)$$

where P^0 and E^0 coincide with P and E in the absence of strains or rotations. We then take our fundamental energy functional to be

$$\mathcal{F}(E^0; e) = \frac{1}{0} \sum_{\text{cell}} E_{\text{cell}}^{(0)} E^0 P^0 \quad (\text{A } 6)$$

where $E_{\text{cell}}^{(0)}$ is the usual zero-field Kohn-Sham energy per cell¹⁴ of the occupied Bloch functions introduced earlier in Sec. IIA.

Note that $P = E = P^0 E$, so that Eq. (A 6) is closely related to Eq. (1). However, it is important to understand that E^0 and e are the "natural variables" of the energy functional (A 6), so that subsequent partial derivatives are defined in terms of this pair of variables. For example, the proper piezoelectric tensor is now given by

$$e_{ij} = \frac{\partial^2 \mathcal{F}}{\partial E^0 \partial e_j} \quad (\text{A } 7)$$

or

$$e_{ij} = \frac{1}{0} \frac{\partial (P^0)}{\partial e_j} : \quad (\text{A } 8)$$

We also emphasize that E^0 is, in many ways, a more natural variable than E from the experimental point of view. For example, if one controls the voltage V across a film of M atomic layers between conducting capacitor plates and observes the resulting strain, one is actually controlling $E^0 = eV/Mc_0 = Ec=c_0$, not E , where c_0 and c are the zero-field and finite-field lattice constants, respectively, in the normal direction.

From Eqs. (A 3) and (A 8) it follows that the improper and proper piezoelectric tensors are related by¹⁵

$$e = e^{\text{impr}} P + P : \quad (\text{A } 9)$$

It is then easy to show that the proper tensor e is symmetric under interchange of indices i and j , so that the Voigt notation can be restored. This is to be expected because the reduced quantity P^0 is invariant under a rigid rotation of the crystal, a fact that follows trivially from Eq. (A 4). That is, P^0 , expressed as a function of the six symmetrized strain variables (Eq. (A 2)) and the three rotational variables, is actually independent of the rotational ones. Indeed, a rigid rotation of the entire system, material plus external field E , leaves both E^0 and P^0 individually unchanged. It is then natural to discard the rotational variables and recast the symmetric strain variables in Voigt notation. We then regard the energy functional of Eq. (A 6) to be a functional $\mathcal{F}(E^0; e)$ of the fundamental variables of rescaled E^0 and Voigt e_j , and the proper piezoelectric tensor may be written as

$$e_{ij} = \frac{\partial^2 \mathcal{F}}{\partial E^0 \partial e_j} = \frac{1}{0} \frac{\partial (P^0)}{\partial e_j} : \quad (\text{A } 10)$$

Restoring the explicit dependence on internal displacements u_m , Eq. (A 6) becomes

$$\mathcal{F}(u; E^0; e) = \frac{1}{0} \sum_{\text{cell}} E_{\text{cell}}^{(0)} E^0 P^0; \quad (\text{A } 11)$$

where $\mathcal{F}(E^0; e)$ of Eq. (A 6) corresponds to the minimum of (A 11) over all possible displacements u_m . While this equation is numerically equal to Eq. (1), it is critical to recall that it is written in terms of different arguments.

Strictly speaking, this notation should have been introduced at the very beginning of Sec. IIA, and every equation throughout the paper, starting with Eq. (1), should have E replaced by E^0 and P by P^0 . For example, Eqs. (8) and Eq. (26) should be replaced by Eqs. (A 12) and

$$e_{ij} = \frac{\partial^2 \mathcal{F}}{\partial E^0 \partial e_j}; \quad (\text{A } 12)$$

respectively, and similarly for all other equations. However, for the purposes of clarity of presentation, it was decided to avoid use of this clumsy notation in the main part of the paper.

Finally, we note that the reduced quantities P^0 and E^0 are also rather natural physical variables from the point of view of computational implementation. Indeed, these two quantities can further be expressed in terms of fully reduced quantities p and a via

$$P^0 = \frac{e}{a} p \quad a^{(0)} \quad (\text{A } 13)$$

and

$$E^0 = e E \quad a^{(0)} \quad (\text{A } 14)$$

so that $P = (e/a) p$ and $E = e E/a$. In these equations, $a^{(0)}$ is the i th undeformed primitive real-space

lattice vector, \mathbf{a} is the corresponding deformed lattice vector, and $\Omega = a_1 a_2 a_3$ is the deformed cell volume. Note that $\mathbf{P} = \mathbf{E} = \mathbf{P}^0 + \mathbf{E} = \mathbf{P}^0 + \mathbf{P}^1$ and

$$e_j = \frac{e}{\Omega} a_j; \quad \frac{\partial p}{\partial a_j} : \quad (\text{A } 15)$$

The fully reduced polarization \mathbf{p} has a simple interpretation in terms of the fractional positions of the charges in the unit cell; for example, the contribution to it coming from the valence band is just $1/2$ times the Berry phase of that band, as can be seen by comparing with Eq. (10) of Ref. 15. Similarly, \mathbf{P}^1 is just e times the electrostatic potential drop across the unit cell in direction \mathbf{a} .

The computational implementation of DFPT is done quite naturally in terms of these reduced quantities,^{7,10,19} and as a result, DFPT automatically yields the proper piezoelectric tensor.¹⁰ This can be a source of confusion when comparing the DFPT results with those of finite-difference calculations. In the latter approach, the polarization is obtained directly from ground-state DFT calculations,⁶ and piezoelectric tensor elements are obtained by numerical differentiation using sufficiently small strains about the reference structure. This procedure yields the improper tensor, however, and Eq. (A 9) must be applied to compare such results with the DFPT ones.¹⁰

¹ P. Hohenberg and W. Kohn, Phys. Rev. 136, B864 (1964); W. Kohn and L. J. Sham, ibid. 140, A1133 (1965).

² X. Gonze, Phys. Rev. A 52, 1086 (1995); 52, 1096 (1995); 55, 10337 (1997); X. Gonze and C. Lee, ibid. 55, 10355 (1997).

³ S. Baroni, S. de Gironcoli, A. Dal Corso, and P. Giannozzi, Rev. Mod. Phys. 73, 515 (2001)

⁴ P. Giannozzi, S. de Gironcoli, P. Pavone, and S. Baroni, Phys. Rev. B 43 7231 (1991); S. Baroni, P. Giannozzi, and A. Testa, Phys. Rev. Lett. 58, 1861 (1987).

⁵ S. de Gironcoli, S. Baroni, and R. Resta, Phys. Rev. Lett. 62, 2853 (1989).

⁶ R. D. King-Smith and D. Vanderbilt, Phys. Rev. B 47, 1651 (1993).

⁷ ABINIT is a common project of the Universit  Catholique de Louvain, Comins Incorporated, and other contributors (<http://www.abinit.org>). X. Gonze, J.-M. Beuken, R. Caracas, F. Detraux, M. Fuchs, G.-M. Rignanese, L. Sindic, M. Verstraete, G. Zerangue, F. Jollet, M. Torrent, A. Roy, M. Mikami, Ph. Ghosez, J.-Y. Raty, and D. C. Allan, Comput. Mater. Sci. 25, 478 (2002).

⁸ S. Baroni, A. Dal Corso, S. de Gironcoli, P. Giannozzi, C. Cavazzoni, G. Ballabio, S. Scandolo, G. Chiarotti, P. Focher, A. Pasquarello, K. Laasonen, A. Trave, R. Car, N. Marzari, A. Kokalj, <http://www.pwscf.org>.

⁹ G. Kresse and J. Hafner, Phys. Rev. B 47, R558 (1993);

G. Kresse and J. Furthm ller, ibid. 54, 11169 (1996). See also <http://cms.mpi.univie.ac.at/vasp>.

¹⁰ D. R. Hamann, D. Vanderbilt, K. Rabe, and X. Wu, submitted to Phys. Rev. B.

¹¹ R. W. Nunes and X. Gonze, Phys. Rev. B 63, 155107 (2001).

¹² I. Souza, J. Iniguez, D. Vanderbilt, Phys. Rev. Lett. 89, 117602 (2002).

¹³ P. Umari and A. Pasquarello, Phys. Rev. Lett. 89, 157602 (2002).

¹⁴ That is, the electrostatic part of $E_{\text{cell}}^{(0)}$ is defined to be $(1/\Omega) \int_{\text{cell}} d\mathbf{r} E_{\text{loc}}^2(\mathbf{r})$, where the local field $E_{\text{loc}}(\mathbf{r})$ is the difference between the microscopic field $E(\mathbf{r})$ and its unit-cell average \bar{E} .

¹⁵ D. Vanderbilt, J. Phys. Chem. Solids 61, 147 (2000).

¹⁶ A. Ballato, IEEE Trans. Ultrason., Ferroelec., Freq. Contr., 42, 916 (1995).

¹⁷ J. F. Nye, Physical properties of crystals (Oxford UP, Oxford 1985).

¹⁸ ANSI/IEEE Standard on Piezoelectricity (ANSI/IEEE Std 176-1987), IEEE Transactions on Sonics and Ultrasonics SU-31, No. 2, 1984.

¹⁹ The capabilities to do these calculations are now incorporated in the latest public release of the ABINIT software package.⁷ Building on the implementation of the strain derivatives for computation of bare elastic, piezoelectric, and internal-strain tensors by Hamann et al.,¹⁰ we modified ABINIT (specifically, the ANADDB module) to provide the functionality of computing the secondary response tensors as described here.

²⁰ In the case of Z and e , the wavefunction derivatives with respect to wavevector are also needed (see Ref. 2).

²¹ N. Troullier and J. L. Martins, Phys. Rev. B 43, 1993 (1991).

²² N. Hill and U. Waghmare, Phys. Rev. B 62, 8802 (2000).

²³ D. M. Ceperley, Phys. Rev. B 18, 3126 (1978); D. M. Ceperley and B. J. Alder, Phys. Rev. Lett. 45, 566 (1980).

²⁴ J. P. Perdew and Y. Wang, Phys. Rev. B 45, 13244 (1992).

²⁵ W. Zhong and D. Vanderbilt, Phys. Rev. B 52, 6301 (1995).

²⁶ D. Berlincourt and H. Jaeger, Phys. Rev. 111, 143 (1958).

²⁷ M. Zgonik, P. Bernasconi, M. Duelli, R. Schlessner, P. Gunter, M. H. Garrett, D. Rytz, Y. Zhu, and X. Wu, Phys. Rev. B 50, 5941 (1994).

²⁸ M. Catti, Y. Noel, R. Dovesi, J. Phys. Chem. Solids 64 2183, (2003).

²⁹ O. Madelung, M. Schultz, and H. Weiss, Numerical Data and Functional Relationships in Science and Technology (Springer-Verlag, Berlin, 1982), Vol. 17.

³⁰ A. W. Hewat, Ferroelectrics, 6, 215 (1974).

³¹ T. C. Damen, S. P. S. Porto, and B. Tell, Phys. Rev. 142, 570 (1966).

³² C. A. Argu  llo, D. L. Rousseau, and S. P. S. Porto, Phys. Rev. 181, 1351 (1969).

³³ Ph. Ghosez, Ph.D. thesis, Universit  Catholique de Louvain, 1997.

³⁴ N. Ashkenov, B. N. Mbenkum, C. Bundesmann, V. Riede, M. Lorenz, D. Spemann, E. M. Kaidashev, A. Kasic, M. Schubert, M. Grundmann, G. Wanger, H. Neumann, V. Darakchieva, H. Arwin, and B. Monem, J. Appl. Phys. 93, 126 (2003).

- ³⁵ B. Wang and C. Sun, *Appl. Opt.* 40, 672 (2001).
- ³⁶ Landolt-Bornstein, O. Madelung (Ed.), *New Series, Group III: Solid State Physics, Low Frequency Properties of Dielectric Crystals: Piezoelectric, Pyroelectric and Related Constants*, vol. 29b, Springer, Berlin, 1993.
- ³⁷ A. DalCorso, M. Posternak, R. Resta, and A. Baldereschi, *Phys. Rev. B* 50, 10715 (1994).
- ³⁸ F. Bernardini, V. Fiorentini, and D. Vanderbilt, *Phys. Rev. B* 56, 10024 (1997).
- ³⁹ H. Cao, V. H. Schmidt, R. Zhang, W. Cao and H. Luo, *J. appl. Phys.* 96, 549 (2004); R. Zhang, B. Jiang, W. Jiang and W. Cao, *Mater. Lett.* 57, 1305 (2003).